


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/707,944	JENSEN ET AL.	
	Examiner	Art Unit	
	Thomas K. Pham	2121	

SEARCHED			
Class	Subclass	Date	Examiner
700	280	11/8/2005	TP
700	286	11/8/2005	TP
700	287	11/8/2005	TP
73	35.09	11/8/2005	TP
73	570	11/8/2005	TP
73	690	11/8/2005	TP
73	862.41	11/8/2005	TP
73	862.59	11/8/2005	TP
73	35.05	11/8/2005	TP
415	157	11/8/2005	TP
415	43,119	11/8/2005	TP
415	117	11/8/2005	TP
415	910,914	11/8/2005	TP

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
PGPub text searched		11/8/2005	TP

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST searched	11/8/2005	TP
Inventors searched	11/8/2005	TP
NPL - IEEE Xplore attached	11/8/2005	TP